Summit Semiconductor

Ice Axe - Slave Module

Model: 444-2213

Report No. FOCU0115

Report Prepared By



www.nwemc.com 1-888-EMI-CERT

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22975 NW Evergreen Parkway Suite 400 Hillsboro, Oregon 97124

Certificate of Test

Last Date of Test: September 27, 2011 Summit Semiconductor Model: Ice Axe - Slave Module

Emissions					
Test Description	Specification	Test Method	Pass/Fail		
Occupied Bandwidth	FCC 15.247:2011	ANSI C63.10:2009	Pass		
Output Power	FCC 15.247:2011	ANSI C63.10:2009	Pass		
Band Edge Compliance	FCC 15.247:2011	ANSI C63.10:2009	Pass		
Spurious Conducted Emissions	FCC 15.247:2011	ANSI C63.10:2009	Pass		
Power Spectral Density	FCC 15.247: 2011	ANSI C63.10:2009	Pass		
Radiated Spurious Emissions	FCC 15.209:2011	ANSI C63.10:2009	Pass		
AC Powerline Conducted Emissions	FCC 15.207:2011	ANSI C63.10:2009	Pass		

Modifications made to the product

See the Modifications section of this report

Test Facility

The measurement facility used to collect the data is located at:

Northwest EMC, Inc. 22975 NW Evergreen Parkway, Suite 400 Hillsboro, OR 97124

Phone: (503) 844-4066 Fax: 844-3826

This site has been fully described in a report filed with and accepted by the FCC (Federal Communications Commission) and Industry Canada (Site filing #2834D-1).

Approved By:

Don Facteau, IS Manager

NVLAP Lab Code: 200630-0

This report must not be used to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the federal government of the United States of America.

Product compliance is the responsibility of the client, therefore the tests and equipment modes of operation represented in this report were agreed upon by the client, prior to testing. This Report may only be duplicated in its entirety. The results of this test pertain only to the sample(s) tested. The specific description is noted in each of the individual sections of the test report supporting this certificate of test.



Revision History

Revision 06/29/09

Revision Number	LIASCRIPTION		Page Number
00	None		



Accreditations and Authorizations

FCC

Accredited by NVLAP for performance of FCC radio, digital, and ISM device testing. Our Open Area Test Sites, certification chambers, and conducted measurement facilities have been fully described in reports filed with the FCC and accepted by the FCC in letters maintained in our files. Northwest EMC has been accredited by ANSI to ISO / IEC Guide 65 as a product certifier. We have been designated by the FCC as a Telecommunications Certification Body (TCB). This allows Northwest EMC to certify transmitters to FCC specifications in accordance with 47 CFR 2.960 and 2.962.

NVLAP

Northwest EMC, Inc. is accredited under the National Voluntary Laboratory Accreditation Program (NVLAP) for satisfactory compliance with the requirements of ISO/IEC 17025 for Testing Laboratories. NVLAP is administered by the National Institute of Standards and Technology (NIST), an agency of the U.S. Commerce Department. The NVLAP accreditation encompasses Electromagnetic Compatibility Testing in accordance with the European Union EMC Directive 2004/108/EC, and ANSI C63.4. Additionally, Northwest EMC is accredited by NVLAP to perform radio testing in accordance with the European Union R&TTE Directive 1999/5/EEC, the requirements of FCC, and the RSS radio standards for Industry Canada.

Industry Canada

Accredited by NVLAP for performance of Industry Canada RSS and ICES testing. Our Open Area Test Sites and certification chambers comply with RSS-Gen, Issue 2 and have been filed with Industry Canada and accepted. Northwest EMC has been accredited by ANSI to ISO / IEC Guide 65 as a product certifier. We have been designated by NIST and recognized by Industry Canada as a Certification Body (CB) per the APEC Mutual Recognition Arrangement (MRA). This allows Northwest EMC to certify transmitters to Industry Canada technical requirements. (Site Filing Numbers - Hillsboro: 2834D-1, 2834D-2, Sultan: 2834C-1, Irvine: 2834B-1, 2834B-2, Brooklyn Park: 2834E-1)

CAB

Designated by NIST and validated by the European Commission as a Conformity Assessment Body (CAB) to conduct tests and approve products to the EMC directive and transmitters to the R&TTE directive, as described in the U.S. - EU Mutual Recognition Agreement.

Australia/New Zealand

The National Association of Testing Authorities (NATA), Australia has been appointed by the ACA as an accreditation body to accredit test laboratories and competent bodies for EMC standards. Accredited test reports or assessments by competent bodies must carry the NATA logo. Test reports made by an overseas laboratory that has been accredited for the relevant standards by an overseas accreditation body that has a Mutual Recognition Agreement (MRA) with NATA are also accepted as technical grounds for product conformity. The report should be endorsed with the respective logo of the accreditation body (NVLAP).



Accreditations and Authorizations

VCCI

Accepted as an Associate Member to the VCCI, Acceptance No. 564. Conducted and radiated measurement facilities have been registered in accordance with Regulations for Voluntary Control Measures, Article 8. (Registration Numbers. - Hillsboro: C-1071, R-1025, G-84, C-2687, T-1658, and R-2318, Irvine: R-1943, G-85, C-2766, and T-1659, Sultan: R-871, G-83, C-3265, and T-1511, Brooklyn Park: R-3125, G-86, G-141, C-3464, and T-1634).

BSMI

Northwest EMC has been designated by NIST and validated by C-Taipei (BSMI) as a CAB to conduct tests as described in the APEC Mutual Recognition Agreement (US0017).

GOST

Northwest EMC, Inc. has been assessed and accredited by the Russian Certification bodies Certinform VNIINMASH, CERTINFO, SAMTES, and Federal CHEC, to perform EMC and Hygienic testing for Information Technology Products. As a result of their laboratory assessment, they will accept test results from Northwest EMC, Inc. for product certification

KCC

Northwest EMC, Inc is a CAB designated by MRA partners and recognized by Korea. (Assigned Lab Numbers: Hillsboro: US0017, Irvine: US0158, Sultan: US0157, Brooklyn Park: US0175)

VIETNAM

Vietnam MIC has approved Northwest EMC as an accredited test lab. Per Decision No. 194/QD-QLCL (dated December 15, 2009), Northwest EMC test reports can be used for Vietnam approval submissions.

SCOPE

For details on the Scopes of our Accreditations, please visit: http://www.nwemc.com/accreditations/



Northwest EMC Locations





Oregon Labs EV01-EV12 22975 NW Evergreen Pkwy Suite 400 Hillsboro, OR 97124 (503) 844-4066 California Labs OC01-OC13 41 Tesla Irvine, CA 92618 (949) 861-8918 Minnesota Labs MN01-MN08 9349 W Broadway Ave. Brooklyn Park, MN 55445 (763) 425-2281 Washington Labs SU01-SU07 14128 339th Ave. SE Sultan, WA 98294 (360) 793-8675 New York Labs WA01-WA04 4939 Jordan Rd. Elbridge, NY 13060 (315) 685-0796







Rev 11/17/06

Party Requesting the Test

Company Name:	Summit Semiconductor		
Address:	22867 NW Bennett St, Suite 200		
City, State, Zip:	Hillsboro, OR 97124		
Test Requested By:	Ponnappa Pasura		
Model:	Ice Axe - Slave Module		
First Date of Test:	September 12, 2011		
Last Date of Test:	September 19, 2011		
Receipt Date of Samples:	September 12, 2011		
Equipment Design Stage:	Preproduction		
Equipment Condition:	No Damage		

Information Provided by the Party Requesting the Test

Functional Description of the EUT (Equipment Under Test):
UNII radio module

Testing Objective:	
Seeking modular approval of the client under FCC 15.247 for operation in the 5.8 GHz band.	

Configurations

Revision 9/21/05

CONFIGURATION 1 FOCU0115

Software/Firmware Running during test				
Description	Version			
Hood BIST Monitor	157			

EUT					
Description	Manufacturer	Model/Part Number	Serial Number		
Wireless Audio Slave Board - Direct Connect	Summit Semiconductor	Ice Axe - Slave Module	03 EA 12 00 5A 6D		

Peripherals in test setup boundary					
Description	Manufacturer	Model/Part Number	Serial Number		
DC Power / RS-232 Serial Interface	Summit Semiconductor	Unknown	None		
DC Block	MCL	BLK-89-S+	15542		
AC Adapter	PHIHONG	PSA21R-033	C22300479A8		

Remote Equipment Outside of Test Setup Boundary				
Description Manufacturer Model/Part Number Serial Number				
Remote PC Dell Latitude D820 2006-00516				

Cables					
Cable Type	Shield	Length (m)	Ferrite	Connection 1	Connection 2
Multi-pin flex cable	No	0.3m	No	Wireless Audio Slave Board - Direct Connect	DC Power / RS-232 Serial Interface
Serial	Yes	2.0m	No	DC Power / RS-232 Serial Interface	Remote PC
DC Lead	PA	1.8m	PA	AC Adapter	DC Power / RS-232 Serial Interface
PA = Cable is permanently attached to the device. Shielding and/or presence of ferrite may be unknown.					

Configurations

CONFIGURATION 4 FOCU0115

Software/Firmware Running during test				
Description	Version			
Hood BIST Monitor	157			

EUT			
Description	Manufacturer	Model/Part Number	Serial Number
Wireless Audio Slave Board - Radiated	Summit Semiconductor	Ice Axe - Slave Module	02 EA 12 00 5A 67

Peripherals in test setup boundary					
Description	Manufacturer	Model/Part Number	Serial Number		
DC Power Supply	Topward	6303D	743645		

Remote Equipment Outside of Test Setup Boundary								
Description	Manufacturer	Model/Part Number	Serial Number					
DC Power / RS-232 Serial Interface	Summit Semiconductor	Unknown	None					
Remote PC	Dell	Latitude D820	2006-00516					

Cables								
Cable Type	Shield	Length (m)	Ferrite	Connection 1	Connection 2			
DC Lead	PA	1.8m	PA	AC Adapter	DC Power / RS-232 Serial Interface			
PA = Ca	PA = Cable is permanently attached to the device. Shielding and/or presence of ferrite may be unknown.							

Revision 4/28/03

	Equipment modifications									
Item	Date	Test	Modification	Note	Disposition of EUT					
1	9/12/2011	Output Power	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.					
2	9/12/2011	Band Edge Compliance	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.					
3	9/12/2011	Occupied Bandwidth	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.					
4	9/12/2011	Power Spectral Density	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.					
5	9/13/2011	Spurious Conducted Emissions	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.					
6	9/15/2011	AC Powerline Conducted Emissions	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.					
7	9/19/2011	Radiated Spurious Emissions	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	Scheduled testing was completed.					

Occupied Bandwidth

Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

TEST EQUIPMENT					
Description	Manufacturer	Model	ID	Last Cal.	Interval
Spectrum Analyzer	Agilent	E4440A	AFD	7/5/2011	12
40GHz DC Block	Miteq	DCB4000	AMD	8/12/2011	12
Attenuator 20 dB, SMA M/F 26GHz	S.M. Electronics	SA26B-20	AUY	8/2/2011	12
EV06 Direct Connect Cable	ESM Cable Corp.	TT	ECA	NCR	0

MEASUREMENT UNCERTAINTY

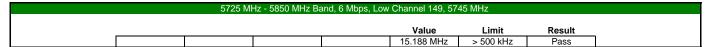
A measurement uncertainty estimation has been performed for each test per our internal quality document WP 342. The estimation is used to compare the measured result with its "true" or theoretically correct value. The expanded measurement uncertainty for radiated emissions measurements is less than +/- 4 dB, and for conducted emissions measurements is less than +/- 2.7 dB. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4; therefore, the test data can be compared directly to the specification limit to determine compliance. The calculations for measurement uncertainty are available upon request.

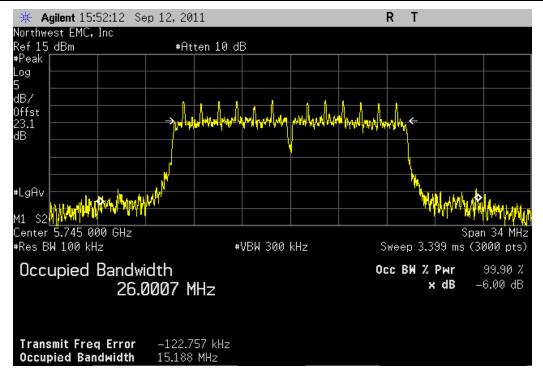
TEST DESCRIPTION

The occupied bandwidth was measured with the EUT set to low, medium, and high transmit frequencies. The measurement was made using a direct connection between the RF output of the EUT and the spectrum analyzer. The EUT was transmitting at its maximum data rate with the typical modulation.

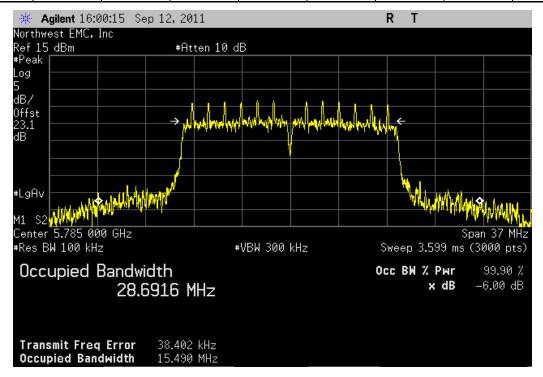
NORTHWEST EMC		Occupio	ed Bandwidth			XMit 2011.08.04 PsaTx 2011.09.07
EUT: Ice Axe - Slave N	lodule			Work Order:		
Serial Number: 03 EA 12 00 5A 6				Date:	09/12/11	
Customer: Summit Semicor				Temperature		
Attendees: Ponnappa Pasur	a			Humidity:		
Project: None				Barometric Pres.:		
Tested by: Rod Peloquin		Power:	3.3 VDC	Job Site:	EV06	
TEST SPECIFICATIONS			Test Method			
FCC 15.247:2011			ANSI C63.10:2009			
COMMENTS						
Operated per TPC power table, data						
DEVIATIONS FROM TEST STANDAR	(D					
No Deviations						
Configuration # 1	Rolly le	Reling				
				Value	Limit	Result
5725 MHz - 5850 MHz Band 6 Mbps						
Low	Channel 149, 5745 MHz			15.188 MHz	> 500 kHz	Pass
	Channel 157, 5785 MHz			15.49 MHz	> 500 kHz	Pass
High	Channel 165, 5825 MHz			14.778 MHz	> 500 kHz	Pass



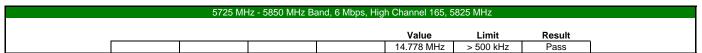


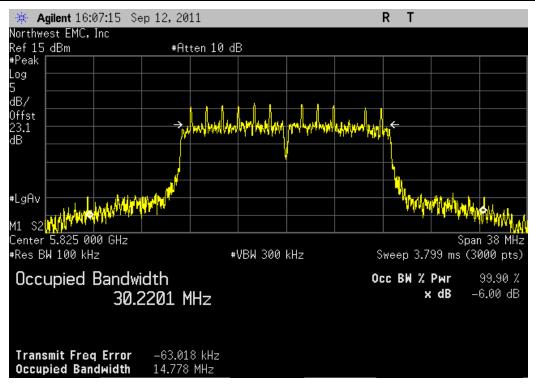


5725 MHz - 5850 MHz Band, 6 Mbps, Mid Channel 157, 5785 MHz							
					Value	Limit	Result
					15.49 MHz	> 500 kHz	Pass



Occupied Bandwidth





Output Power

Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

TEST EQUIPMENT					
Description	Manufacturer	Model	ID	Last Cal.	Interval
Spectrum Analyzer	Agilent	E4440A	AFD	7/5/2011	12
EV06 Direct Connect Cable	ESM Cable Corp.	TT	ECA	NCR	0
40GHz DC Block	Miteq	DCB4000	AMD	8/12/2011	12
Attenuator 20 dB, SMA M/F 26GHz	S.M. Electronics	SA26B-20	AUY	8/2/2011	12
Attenuator, 6dB	S.M. Electronics	18N-06	AWN	5/5/2011	12
Power Meter	Gigatronics	8651A	SPM	1/7/2010	24
Power Sensor	Gigatronics	80701A	SPL	7/8/2011	24
MXG Vector Signal Generator	Agilent	N5182A	TIF	NCR	0

MEASUREMENT UNCERTAINTY

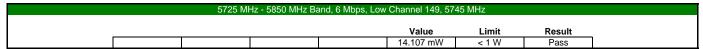
A measurement uncertainty estimation has been performed for each test per our internal quality document WP 342. The estimation is used to compare the measured result with its "true" or theoretically correct value. The expanded measurement uncertainty for radiated emissions measurements is less than +/- 4 dB, and for conducted emissions measurements is less than +/- 2.7 dB. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4; therefore, the test data can be compared directly to the specification limit to determine compliance. The calculations for measurement uncertainty are available upon request.

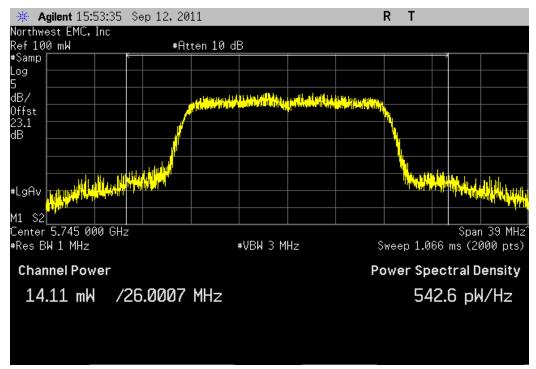
TEST DESCRIPTION

The transmit frequency was set to the required channels in each band, at each of the required data rates. The transmit power was set to its default maximum. A direct connection was made between the RF output of the EUT and a spectrum analyzer. Attenuation and a DC block were used. The reference level offset on the spectrum analyzer was adjusted to compensate for cable loss and the external attenuation used between the RF output and the spectrum analyzer input. The amplitude accuracy of the spectrum analyzer was further enhanced by calibrating the setup using the power meter and synthesized signal generator.

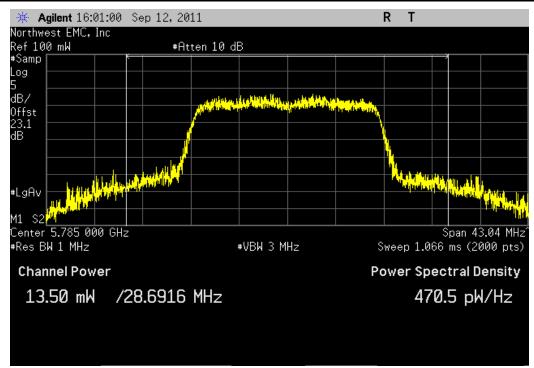
- Prior to measuring peak transmit power; the emission bandwidth (B) was measured.
- Power was integrated across "B", by using the channel power function of the spectrum analyzer and its default bandwidths.

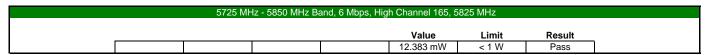
NORTHWEST EMC	Output Power			XMit 2011.08.04 PsaTx 2011.09.07
	0			
EUT: Ice Axe - Slave Module		Work Order:		
Serial Number: 03 EA 12 00 5A 6D			09/12/11	
Customer: Summit Semiconductor		Temperature:		
Attendees: Ponnappa Pasura		Humidity:		
Project: None		Barometric Pres.:		
Tested by: Rod Peloquin	Power: 3.3 VDC	Job Site:	EV06	
TEST SPECIFICATIONS	Test Method			
FCC 15.247:2011	ANSI C63.10:2009			
COMMENTS				
Operated per TPC power table, data randomization enabled.				
DEVIATIONS FROM TEST STANDARD				
No Deviations				
	Le Reley			
		Value	Limit	Result
5725 MHz - 5850 MHz Band 6 Mbps				
Low Channel 149, 5745 MHz		14.107 mW	< 1 W	Pass
Mid Channel 157, 5785 MHz		13.5 mW	< 1 W	Pass
High Channel 165, 5825 MHz		12.383 mW	< 1 W	Pass





5725 MHz - 5850 MHz Band, 6 Mbps, Mid Channel 157, 5785 MHz							
					Value	Limit	Result
					13.5 mW	< 1 W	Pass







Band Edge Compliance

Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

TEST EQUIPMENT					
Description	Manufacturer	Model	ID	Last Cal.	Interval
Spectrum Analyzer	Agilent	E4440A	AFD	7/5/2011	12
40GHz DC Block	Miteq	DCB4000	AMD	8/12/2011	12
Attenuator 20 dB, SMA M/F 26GHz	S.M. Electronics	SA26B-20	AUY	8/2/2011	12
EV06 Direct Connect Cable	ESM Cable Corp.	TT	ECA	NCR	0

MEASUREMENT UNCERTAINTY

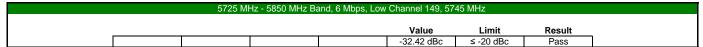
A measurement uncertainty estimation has been performed for each test per our internal quality document WP 342. The estimation is used to compare the measured result with its "true" or theoretically correct value. The expanded measurement uncertainty for radiated emissions measurements is less than +/- 4 dB, and for conducted emissions measurements is less than +/- 2.7 dB. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4; therefore, the test data can be compared directly to the specification limit to determine compliance. The calculations for measurement uncertainty are available upon request.

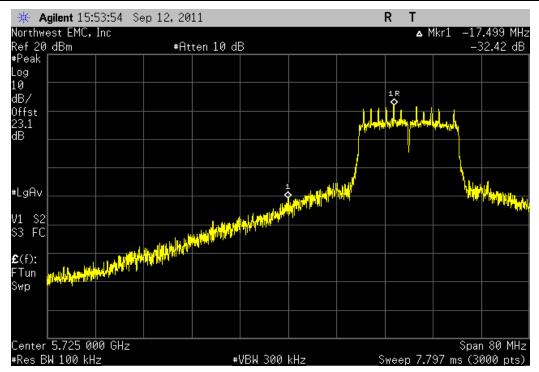
TEST DESCRIPTION

The spurious RF conducted emissions at the edges of the authorized bands were measured with the EUT set to low and high transmit frequencies in each available band. The channels closest to the band edges were selected. The measurement was made using a direct connection between the RF output of the EUT and the spectrum analyzer. The EUT was transmitting at its only data rate available.

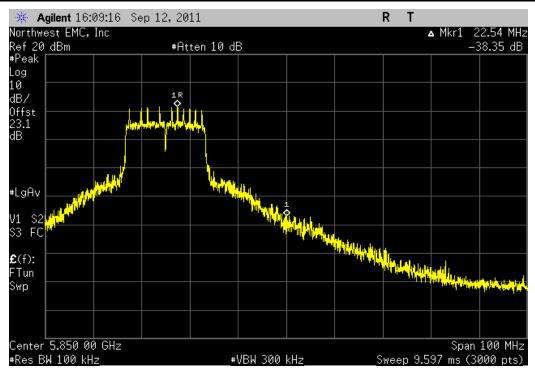
The spectrum was scanned across each band edge from at least 10 MHz below the band edge to 10 MHz above the band edge.

NORTHWEST EMC	1	Band Edge Compliance			XMit 2011.08.04 PsaTx 2011.09.07
EUT: Ice Axe	- Slave Module		Work Order:	FOCU0115	
Serial Number: 03 EA 1	2 00 5A 6D		Date:	09/12/11	
Customer: Summit			Temperature:		
Attendees: Ponnap	pa Pasura		Humidity:		
Project: None			Barometric Pres.:		
Tested by: Rod Pel	oquin	Power: 3.3 VDC	Job Site:	EV06	
TEST SPECIFICATIONS		Test Method			
FCC 15.247:2011		ANSI C63.10:2009			
COMMENTS					
Operated per TPC power tal DEVIATIONS FROM TEST S	ble, data randomization enabled.				
No Deviations	TANDAND				
Configuration #	1 Signature	Reling,			
			Value	Limit	Result
5725 MHz - 5850 MHz Band 6 Mbps					
	Low Channel 149, 5745 MHz High Channel 165, 5825 MHz		-32.42 dBc -38.35 dBc	≤ -20 dBc ≤ -20 dBc	Pass Pass





Volum Limit Deput		5725 MH	Hz - 5850 MHz Ba	ınd, 6 Mbps, High	Channel 165, 58	25 MHz	
					Value	Limit	Result
					-38.35 dBc	≤ -20 dBc	Pass



Spurious Conducted Emissions

Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

TEST EQUIPMENT					
Description	Manufacturer	Model	ID	Last Cal.	Interval
Spectrum Analyzer	Agilent	E4446A	AAQ	6/24/2011	12
40GHz DC Block	Miteq	DCB4000	AMD	8/12/2011	12
Attenuator	Weinschel Corp.	54A-20	RBL	10/11/2010	12
EV06 Direct Connect Cable	ESM Cable Corp.	TT	ECA	NCR	0

MEASUREMENT UNCERTAINTY

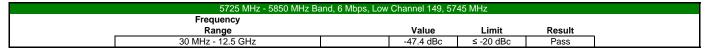
A measurement uncertainty estimation has been performed for each test per our internal quality document WP 342. The estimation is used to compare the measured result with its "true" or theoretically correct value. The expanded measurement uncertainty for radiated emissions measurements is less than +/- 4 dB, and for conducted emissions measurements is less than +/- 2.7 dB. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4; therefore, the test data can be compared directly to the specification limit to determine compliance. The calculations for measurement uncertainty are available upon request.

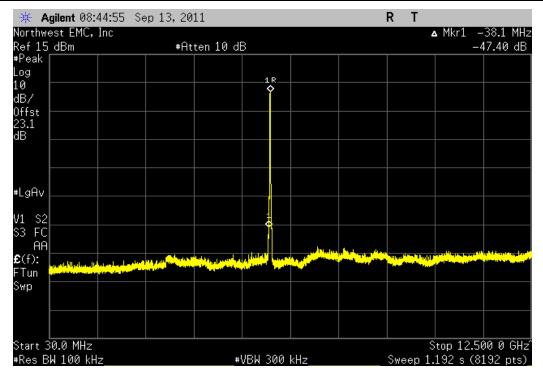
TEST DESCRIPTION

The spurious RF conducted emissions were measured with the EUT set to low, medium, and high transmit frequencies. The measurements were made using a direct connection between the RF output of the EUT and the spectrum analyzer. The EUT was transmitting at its maximum data rate using direct sequence modulation. For each transmit frequency, the spectrum was scanned throughout the specified frequency range.

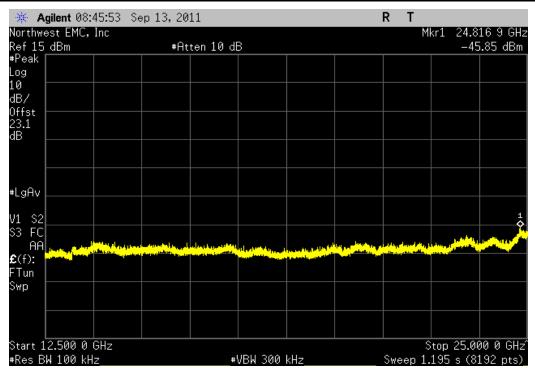
NORTHWEST			XMit 2011.08.04
EMC	Spurious Conducted Emissions	5	PsaTx 2011.09.07
EUT: Ice Axe - Slave Module		Work Order: FOCU011	5
Serial Number: 03 EA 12 00 5A 6D		Date: 09/13/11	
Customer: Summit Semiconductor		Temperature: 23.7°C	
Attendees: None		Humidity: 47%	
Project: None		Barometric Pres.: 30.11	
Tested by: Rod Peloquin	Power: 3.3 VDC	Job Site: EV06	
TEST SPECIFICATIONS	Test Method		
FCC 15.247:2011	ANSI C63.10:2009		
COMMENTS			
Operated per TPC power table, data randomization enabled.			
DEVIATIONS FROM TEST STANDARD			
No Deviations			
Configuration #	Roching be Relenge		
Comigaration #	gnature		
31	Frequency		
	Range	Value Lim	it Result
5725 MHz - 5850 MHz Band	rungo	14140	n nooun
6 Mbps			
Low Channel 149, 5745 MHz	30 MHz - 12.5 GHz	-47.4 dBc ≤ -20	dBc Pass
Low Channel 149, 5745 MHz	12.5 GHz - 25 GHz	-47.46 dBc ≤ -20	dBc Pass
Low Channel 149, 5745 MHz	25 GHz - 32 GHz	-45.76 dBc ≤ -20	dBc Pass
Low Channel 149, 5745 MHz	32 GHz - 40 GHz	-36 dBc ≤ -20	dBc Pass
Mid Channel 157, 5785 MHz	30 MHz - 12.5 GHz	-54.37 dBc ≤ -20	dBc Pass
Mid Channel 157, 5785 MHz	12.5 GHz - 25 GHz	-48.21 dBc ≤ -20	dBc Pass
Mid Channel 157, 5785 MHz	25 GHz - 32 GHz	-45.59 dBc ≤ -20	
Mid Channel 157, 5785 MHz	32 GHz - 40 GHz	-36.3 dBc ≤ -20	
High Channel 165, 5825 MHz	30 MHz - 12.5 GHz	-53.83 dBc ≤ -20	
High Channel 165, 5825 MHz	12.5 GHz - 25 GHz	-47.28 dBc ≤ -20	
High Channel 165, 5825 MHz	25 GHz - 32 GHz	-44.45 dBc ≤ -20	
High Channel 165, 5825 MHz	32 GHz - 40 GHz	-35.21 dBc ≤ -20	dBc Pass



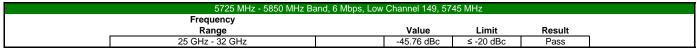


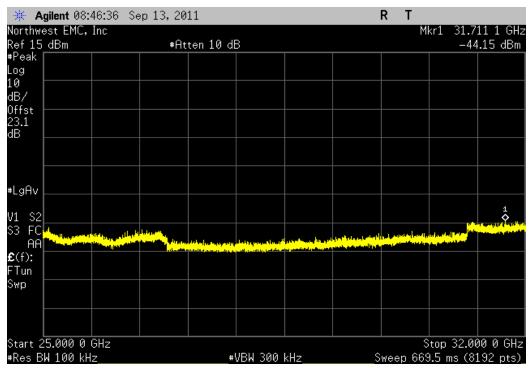


5725 MHz - 5850 MHz Band, 6 Mbps, Low Channel 149, 5745 MHz					
Frequency					
Range		Value	Limit	Result	
12.5 GHz - 25 GHz		-47.46 dBc	≤ -20 dBc	Pass	i

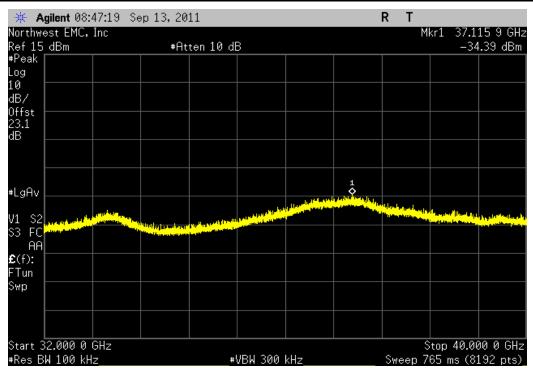




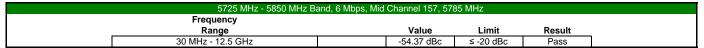


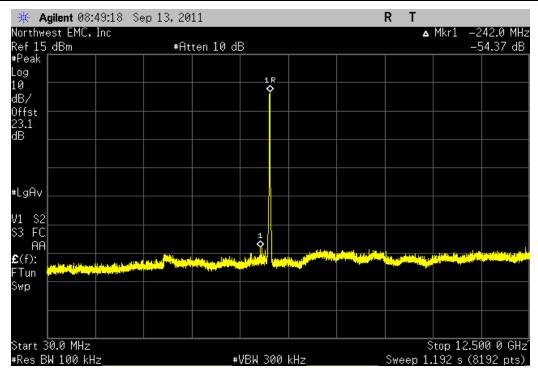


5725 MHz - 5850 MHz Band, 6 Mbps, Low Channel 149, 5745 MHz					
Frequency					
Range		Value	Limit	Result	
32 GHz - 40 GHz		-36 dBc	≤ -20 dBc	Pass	l

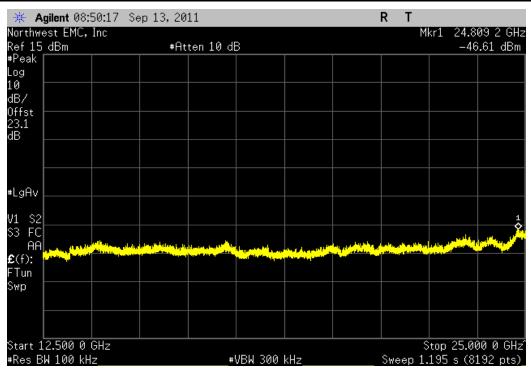




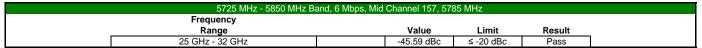


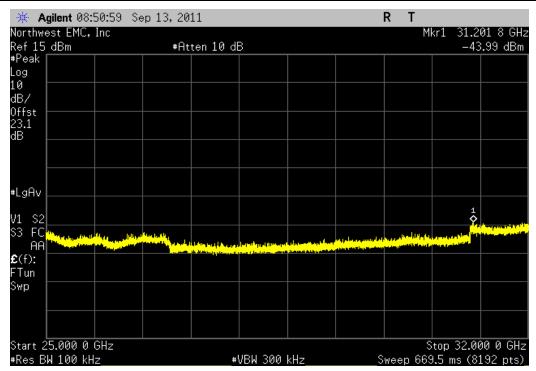


	5725 MHz - 5850 MHz Band, 6 Mbps, Mid Channel 157, 5785 MHz					
	Frequency					
	Range		Value	Limit	Result	
ĺ	12.5 GHz - 25 GHz		-48.21 dBc	≤ -20 dBc	Pass	

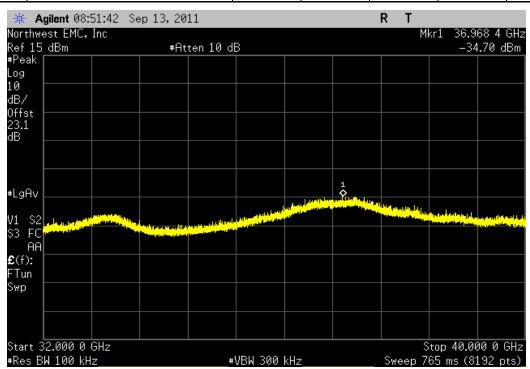






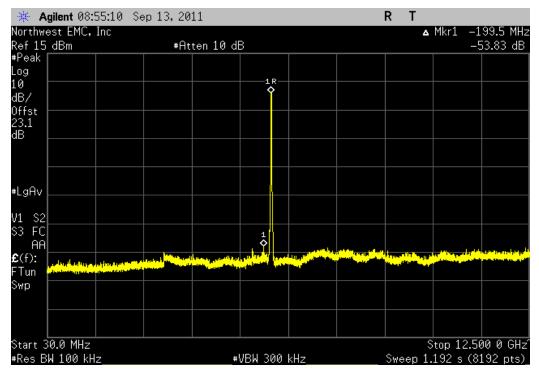


5725 MHz - 5850 MHz Band, 6 Mbps, Mid Channel 157, 5785 MHz				
Frequency				
Range		Value	Limit	Result
32 GHz - 40 GHz		-36.3 dBc	≤ -20 dBc	Pass

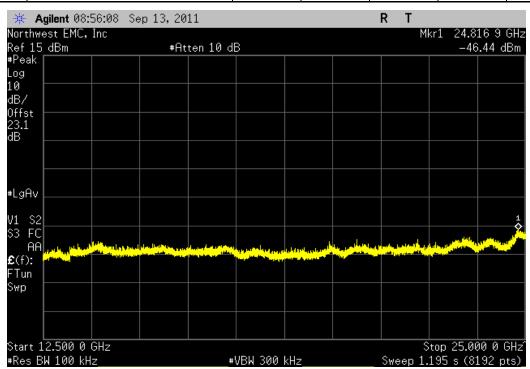




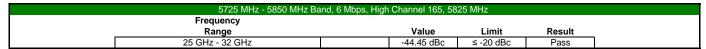


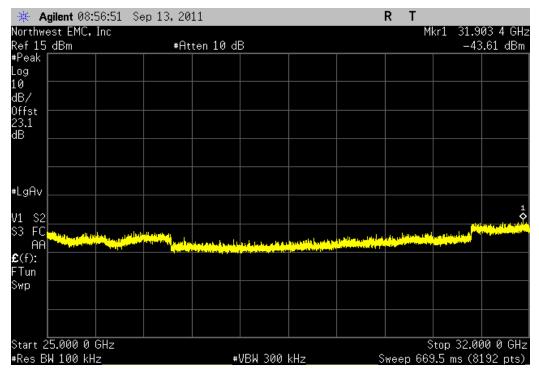


5725 MHz - 5850 MHz Band, 6 Mbps, High Channel 165, 5825 MHz				
Frequency				
Range		Value	Limit	Result
12.5 GHz - 25 GHz		-47.28 dBc	≤ -20 dBc	Pass

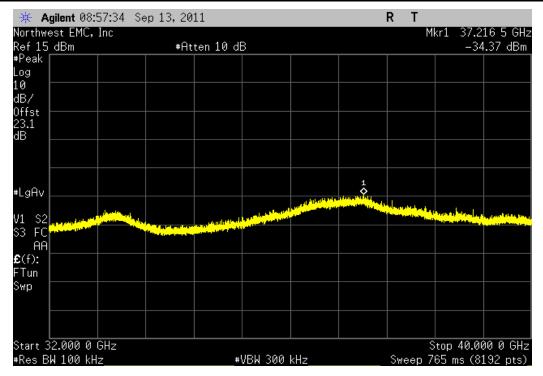








5725 MHz - 5850 MHz Band, 6 Mbps, High Channel 165, 5825 MHz					
Frequency					
Range		Value	Limit	Result	
32 GHz - 40 GHz		-35.21 dBc	≤ -20 dBc	Pass	l



Power Spectral Density

Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

TEST EQUIPMENT					
Description	Manufacturer	Model	ID	Last Cal.	Interval
Spectrum Analyzer	Agilent	E4440A	AFD	7/5/2011	12
40GHz DC Block	Miteq	DCB4000	AMD	8/12/2011	12
Attenuator 20 dB, SMA M/F 26GHz	S.M. Electronics	SA26B-20	AUY	8/2/2011	12
EV06 Direct Connect Cable	ESM Cable Corp.	TT	ECA	NCR	0
Power Meter	Gigatronics	8651A	SPM	1/7/2010	24
Power Sensor	Gigatronics	80701A	SPL	7/8/2011	24
MXG Vector Signal Generator	Agilent	N5182A	TIF	NCR	0

MEASUREMENT UNCERTAINTY

A measurement uncertainty estimation has been performed for each test per our internal quality document WP 342. The estimation is used to compare the measured result with its "true" or theoretically correct value. The expanded measurement uncertainty for radiated emissions measurements is less than +/- 4 dB, and for conducted emissions measurements is less than +/- 2.7 dB. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4; therefore, the test data can be compared directly to the specification limit to determine compliance. The calculations for measurement uncertainty are available upon request.

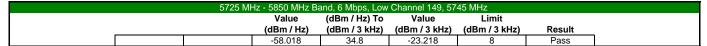
TEST DESCRIPTION

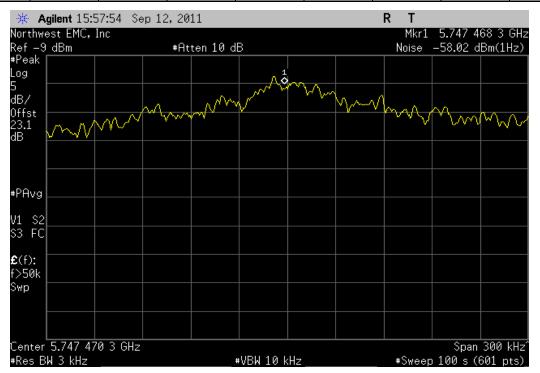
The power spectral density measurements were measured with the EUT set to low, mid, and high transmit frequencies. The measurement was made using a direct connection between the RF output of the EUT and the spectrum analyzer. The EUT was transmitting at its maximum data rate for each modulation type available. ANSI C63.10:2009, Section 6.11.2.3 was followed. The spectrum analyzer was set as follows:

The emission peak was located and zoomed in on within the passband.

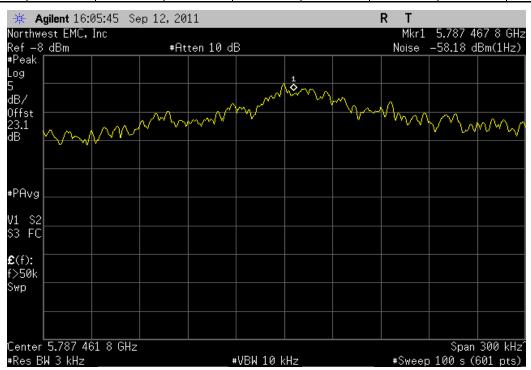
- a) RBW = 3 kHz
- b) VBW = 10 kHz
- c) Span = 300 kHz
- d) Sweep time = 100s
- e) Trace set to MAX
- f) The 1 hz Marker Noise function on the analyzer was used. The data was corrected to 3 kHz by adding 34.8 dB to the reading.

NORTHWEST EMC		Power Spectral Density				XMit 2011.08.04 PsaTx 2011.09.07
		1 7		Week Onder	FOOLIOAAF	
	Axe - Slave Module			Work Order:		
Serial Number: 03 E	mit Semiconductor			Temperature:	09/12/11	
Attendees: Ponr				Humidity:		
Project: None		Power: 3.3 VDC	-	Barometric Pres.:		
Tested by: Rod		Test Method		Job Site:	EV06	
		ANSI C63.10:2009				
FCC 15.247:2011		ANSI C63.10:2009				
COMMENTO						
COMMENTS						
Operated per TPC power	r table, data randomization enabled.					
DEVIATIONS FROM TES	ST STANDARD					
No Deviations						
Configuration #	1 Signature	Reley				
		Value (dBm / Hz)	(dBm / Hz) To (dBm / 3 kHz)	Value (dBm / 3 kHz)	Limit (dBm / 3 kHz)	Result
5725 MHz - 5850 MHz Ba						
6 Mb						
	Low Channel 149, 5745 MHz	-58.018	34.8	-23.218	8	Pass
	Mid Channel 157, 5785 MHz	-58.178	34.8	-23.378	8	Pass
	High Channel 165, 5825 MHz	-58.391	34.8	-23.591	8	Pass

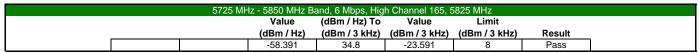


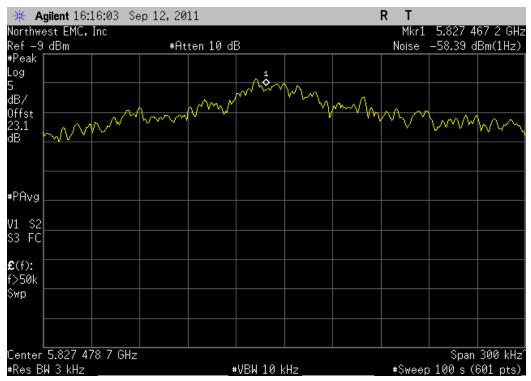


5725 MHz - 5850 MHz Band, 6 Mbps, Mid Channel 157, 5785 MHz						
		Value	(dBm / Hz) To	Value	Limit	
		(dBm / Hz)	(dBm / 3 kHz)	(dBm / 3 kHz)	(dBm / 3 kHz)	Result
		-58.178	34.8	-23.378	8	Pass



Power Spectral Density





RADIATED SPURIOUS EMISSIONS

Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

MODES OF OPERATION

Transmitting 6 Mbps

CHANNELS TESTED

Channel 149 (30), 5745 MHz Channel 157 (32), 5785 MHz

Channel 165 (34), 5825 MHz

POWER SETTINGS INVESTIGATED

3.3 VDC

FREQUENCY RANGE INVESTIGATED

Start Frequency 30 MHz Stop Frequency 40 GHz

SAMPLE CALCULATIONS

Radiated Emissions: Field Strength = Measured Level + Antenna Factor + Cable Factor - Amplifier Gain + Distance Adjustment Factor + External Attenuation

TEST EQUIPMENT					
Description	Manufacturer	Model	ID	Last Cal.	Interval
Spectrum Analyzer	Agilent	E4446A	AAQ	6/24/2011	12
5.725-5.875 Notch Filter	Micro-Tronics	BRC50705	HGJ	8/6/2010	24
5.47-5.725 Notch Filter	Micro-Tronics	BRC50704	HGI	10/8/2010	24
High Pass Filter	Micro-Tronics	HPM50112	HGA	10/8/2010	24
5.25 GHz Notch Filter	K&L Microwave	8N50-5250/X200-0/0	HFK	4/2/2010	24
Pre-Amplifier	Miteq	AM-1616-1000	AOL	6/28/2011	12
Antenna, Bilog	Teseq	CBL 6141B	AXR	11/29/2010	12
EV01 Cables	N/A	Bilog Cables	EVA	6/28/2011	12
Pre-Amplifier	Miteq	AMF-4D-010100-24-10P	APW	6/28/2011	12
Antenna, Horn	ETS	3115	AIZ	1/24/2011	24
EV01 Cables	N/A	Double Ridge Horn Cables	EVB	6/28/2011	12
Antenna, Horn	ETS	3160-07	AHU	NCR	0
Antenna, Horn	ETS	3160-08	AHV	NCR	0
Pre-Amplifier	Miteq	AMF-6F-12001800-30-10P	AVD	3/2/2011	12
Pre-Amplifier	Miteq	AMF-6F-08001200-30-10P	AVC	3/2/2011	12
EV01 Cables	N/A	Standard Gain Horns Cables	EVF	3/2/2011	12
Antenna, Horn	ETS Lindgren	3160-09	AIV	NCR	0
Pre-Amplifier	Miteq	AMF-6F-18002650-25-10P	AVU	9/12/2011	12
Cable	ESM Cable Corp.	KMKM-72	EVY	9/12/2011	12
Antenna, Horn	ETS Lindgren	3160-10	AIW	NCR	0
Pre-Amplifier	Miteq	JSW45-26004000-40-5P	AVR	7/1/2011	12
OC Cable	ESM Cable Corp.	KMKM-72	OCV	7/1/2011	12

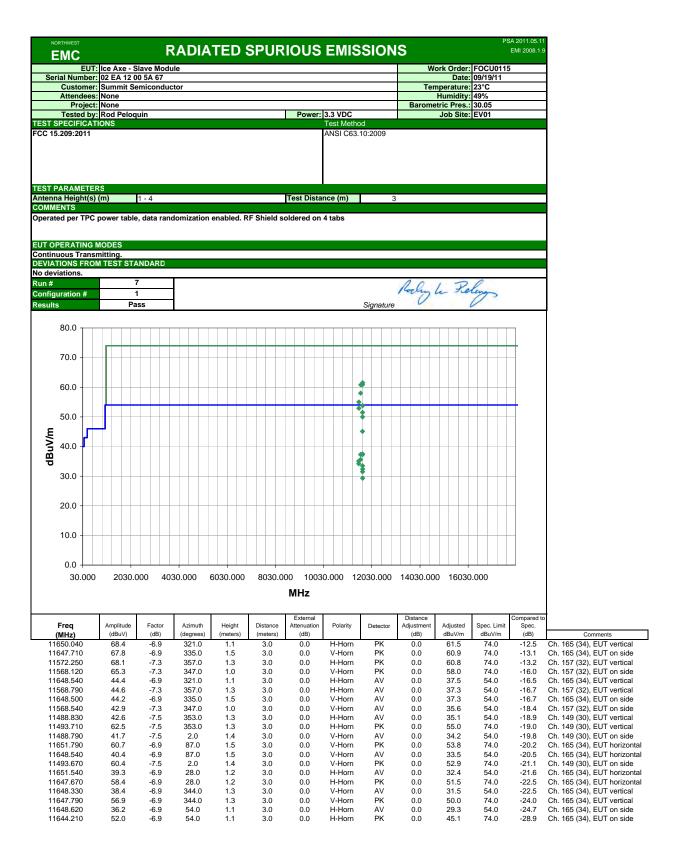
MEASUREMENT BANDWIDTHS					
	Frequency Range	Peak Data	Quasi-Peak Data	Average Data	
	(MHz)	(kHz)	(kHz)	(kHz)	
	0.01 - 0.15	1.0	0.2	0.2	
	0.15 - 30.0	10.0	9.0	9.0	
	30.0 - 1000	100.0	120.0	120.0	
	Above 1000	1000.0	N/A	1000.0	
Measurements were made using the bandwidths and detectors, specified. No video filter was used					

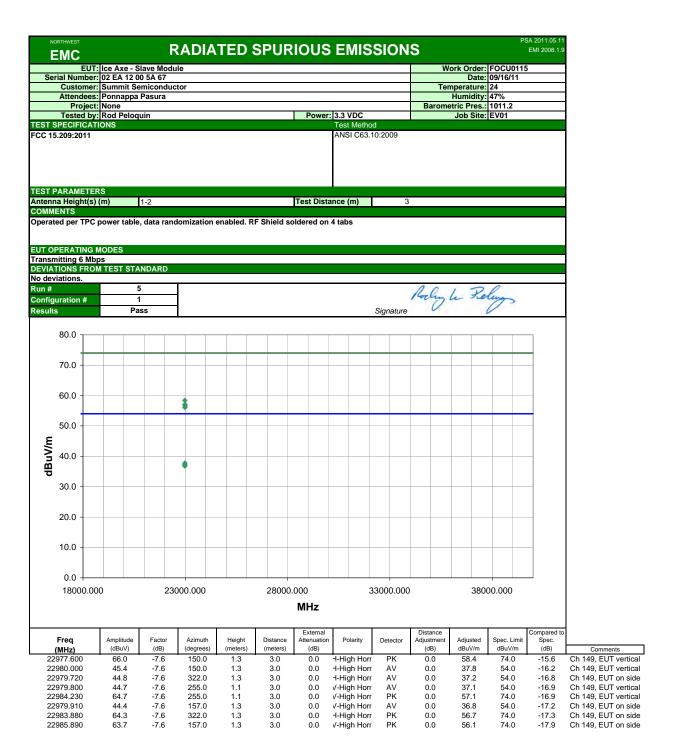
MEASUREMENT UNCERTAINTY

A measurement uncertainty estimation has been performed for each test per our internal quality document WP 342. The estimation is used to compare the measured result with its "true" or theoretically correct value. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4. The measurement uncertainty estimation is available upon request.

TEST DESCRIPTION

The highest gain of each type of antenna to be used with the EUT was tested. The EUT was configured for low, mid, and high band transmit frequencies. For each configuration, the spectrum was scanned throughout the specified range. In addition, measurements were made in the restricted bands to verify compliance. While scanning, emissions from the EUT were maximized by rotating the EUT on a turntable, adjusting the position of the EUT and the EUT antenna in three orthogonal axis, and adjusting measurement antenna height and polarization, and manipulating the EUT antenna in 3 orthogonal planes (per ANSI C63.10:2009). A preamp and high pass filter were used for this test in order to provide sufficient measurement sensitivity.







AC POWERLINE CONDUCTED EMISSIONS

Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

MODES OF OPERATION

Transmitting Channel 165 (34) 5825 MHz

Transmitting Channel 157 (32) 5785 MHz

Transmitting Channel 149 (30) 55745 MHz

POWER SETTINGS INVESTIGATED

3.3 VDC via 120VAC/60Hz

CONFIGURATIONS INVESTIGATED

FOCU0115 -4

SAMPLE CALCULATIONS

Conducted Emissions: Adjusted Level = Measured Level + Transducer Factor + Cable Attenuation Factor + External Attenuator

TEST EQUIPMENT						
Description	Manufacturer	Model	ID	Last Cal.	Interval	
Receiver	Rohde & Schwarz	ESCI	ARH	3/30/2011	12 mo	
High Pass Filter	TTE	H97-100K-50-720B	HFX	2/9/2011	24 mo	
Attenuator	Coaxicom	66702 2910-20	ATO	7/20/2011	12 mo	
LISN	Solar	9252-50-R-24-BNC	LIR	2/17/2011	12 mo	
EV07 Cables	N/A	Conducted Cables	EVG	6/17/2011	12 mo	

MEASUREMENT BANDWIDTHS					
	Frequency Range	Peak Data	Quasi-Peak Data	Average Data	
	(MHz)	(kHz)	(kHz)	(kHz)	
	0.01 - 0.15	1.0	0.2	0.2	
	0.15 - 30.0	10.0	9.0	9.0	
	30.0 - 1000	100.0	120.0	120.0	
	Above 1000	1000.0	N/A	1000.0	
Measurements were made using the bandwidths and detectors specified. No video filter was used.					

MEASUREMENT UNCERTAINTY

A measurement uncertainty estimation has been performed for each test per our internal quality document WP 342. The estimation is used to compare the measured result with its "true" or theoretically correct value. The expanded measurement uncertainty for radiated emissions measurements is less than +/- 4 dB, and for conducted emissions measurements is less than +/- 2.7 dB. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4; therefore, the test data can be compared directly to the specification limit to determine compliance. The calculations for measurement uncertainty are available upon request.

TEST DESCRIPTION

The EUT will be powered either directly or indirectly from the AC power line. Therefore, conducted emissions measurements were made on the AC input of the EUT, or on the AC input of the device used to power the EUT. The AC power line conducted emissions were measured with the EUT operating at the lowest, the highest, and a middle channel in the operational band. The EUT was transmitting at its maximum data rate. For each mode, the spectrum was scanned from 150 kHz to 30 MHz. The test setup and procedures were in accordance with ANSI C63.10-2009.

10.7

20.1

30.8

56.0

-25.2

2.328

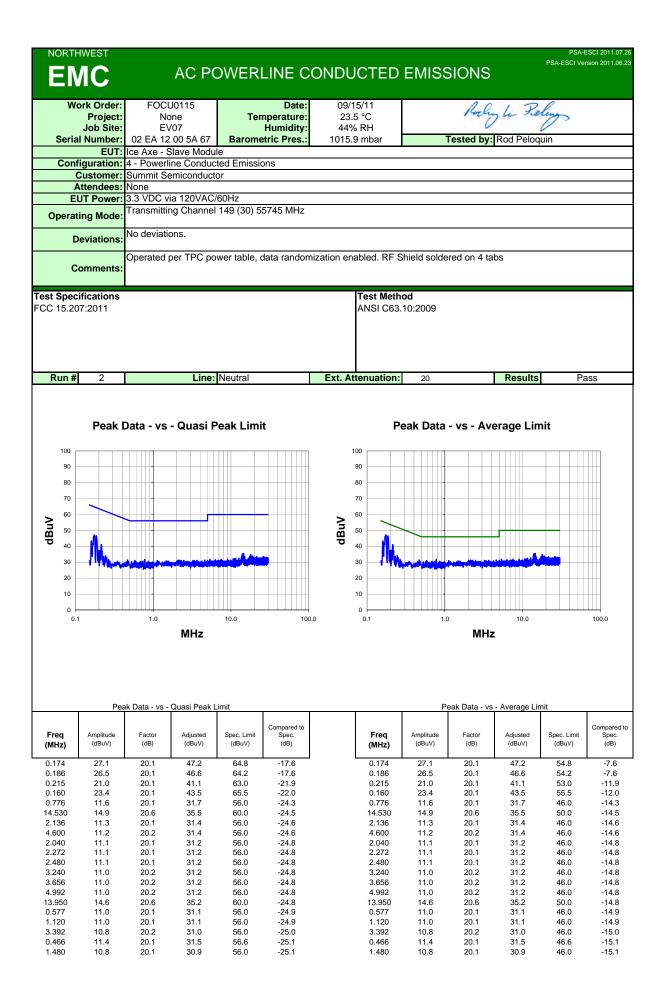
10.7

20.1

30.8

46.0

-15.2



18.0

20.1

38.1

53.3

-15.2

0.208

18.0

20.1

38.1

63.3

-25.2

10.6

20.2

30.8

56.0

-25.2

4.152

20.2

10.6

30.8

46.0

-15.2

3.872

11.2

11.1

20.1

20.2

31.3

31.3

56.0

56.0

-24.7

-24.7

1.024

3.872

11.2

11.1

20.1

20.2

31.3

31.3

46.0

46.0

-14.7

-14.7

